

Search Notes



Application/Control No.

10/721,389

Examiner

Duy M. Dang

Applicant(s)/Patent under
Reexamination

HATANAKA ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	232-239 244 246	5/30/2007	DD
348	397.1		
	407.1		
	620		
375	240		
	240.1		
358	1.15		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East (uspto, derwent, jpo, epo), see printouts	5/30/07 6/6/07	DD
Inventor search (east) see printouts		